

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/629,131	YEH ET AL.
	Examiner	Art Unit
	HUYEN X. VO	2626

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
704	270; 257	9/1/2008	HV
704	1; 9	9/1/2008	HV
715	208; 239	9/1/2008	HV
	715/205	9/1/2008	HV